IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re: Adam William Saxler

Application Serial No.: To be assigned

Filed: Concurrently herewith

For: NITRIDE HETEROJUNCTION TRANSISTORS HAVING CHARGE-TRANSFER INDUCED ENERGY BARRIERS AND METHODS OF FABRICATING THE SAME

Date: February 5, 2004

MAIL STOP PATENT APPLICATION Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(b)

Sir:

Attached is a list of documents on Form PTO-1449, together with a copy of any listed foreign patent document and/or non-patent literature. A copy of any listed U.S. patent and/or U.S. patent application publication is not provided herewith in accordance with the waiver by the U.S. Patent and Trademark Office of requirements under 37 C.F.R. § 1.98(a)(2)(i) for all U.S. national patent applications filed after June 30, 2003 and for all international applications that have entered the national stage under 35 USC § 371 after June 30, 2003.

It is requested that these documents be considered by the Examiner and officially made of record in accordance with the provisions of 37 C.F.R. § 1.56 and Section 609 of the MPEP. No fee is believed due; however, the Commissioner is hereby authorized to charge any deficiency or credit any overpayment to Deposit Account No. 50-0220.

Respectfully submitted,

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Traci A. Brown

FORM PTO-1449 U.S. Department of Commerce
Patent and Trademark Office
LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)

Attorney Docket Number: 5308-389

Serial No.:
To be determined

Applicants: Adam William Saxler

Filing Date: Concurrently herewith

Group: Uknown

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